


<b>Search Notes</b>  	<b>Application/Control No.</b>  10517319	<b>Applicant(s)/Patent Under Reexamination</b>  TESSIER ET AL.
	<b>Examiner</b>  Wen, Sharon	<b>Art Unit</b>  1644

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
inventor name search PALM EAST DIALOG	8/14/2007	SW
key word search EAST DIALOG	8/14/2007	SW
priority document	8/14/2007	SW
New Matter discussed with SPE C. Chan	8/13/2007	SW

INTERFERENCE SEARCH			
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